

<b>Notice of References Cited</b>	Application/Control No. 10/594,071		Applicant(s)/Patent Under Reexamination TOBISAKA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0016216	01-2005	Kim et al.	065/384
*	B	US-2002/0148257	10-2002	Shimizu et al.	65/377
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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